



Application

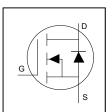
- Brushed Motor drive applications
- **BLDC** Motor drive applications
- Battery powered circuits
- Half-bridge and full-bridge topologies
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
- DC/DC and AC/DC converters
- DC/AC Inverters

Benefits

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free, RoHS Compliant



HEXFET® Power MOSFET



V _{DSS}	40V
R _{DS(on)} typ.	2.0mΩ
max	2.5m $Ω$
I _D	95A



G	D	S
Gate	Drain	Source

Base next number	Dookogo Tymo	Standard Pa	ck	Orderable Part Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
IRFI7440GPbF	TO-220 Full-Pak	Tube	50	IRFI7440GPbF

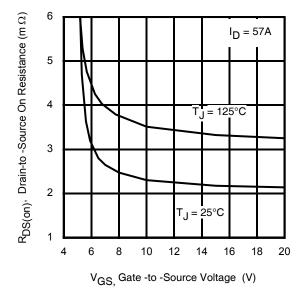


Fig 1. Typical On-Resistance vs. Gate Voltage

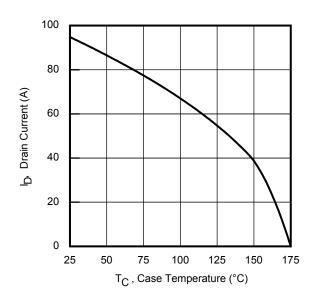


Fig 2. Maximum Drain Current vs. Case Temperature

2015-12-16



Absolute Maximium Rating

Symbol	Parameter	Max.	Units
I_D @ T_C = 25°C	Continuous Drain Current, V _{GS} @ 10V	95	
$I_D @ T_C = 100^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V	67	Α
I _{DM}	Pulsed Drain Current ①	380	
$P_D @ T_C = 25^{\circ}C$	Maximum Power Dissipation	42	W
	Linear Derating Factor	0.28	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
TJ	Operating Junction and Storage Temperature Range	-55 to + 175	Ĵ
T _{STG}	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting Torque, 6-32 or M3 Screw	10 lbf·in (1.1 N·m)	

Avalanche Characteristics

E _{AS (Thermally limited)}	Single Pulse Avalanche Energy ②	201	m l
E _{AS (Thermally limited)}	Single Pulse Avalanche Energy ®	407	mJ
I_{AR}	Avalanche Current ①	Coo Fig. 15, 16, 220, 22b	Α
E _{AR}	Repetitive Avalanche Energy ①	See Fig. 15, 16, 23a, 23b	mJ

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case ⑦		3.6	°C/\\/
$R_{ heta JA}$	Junction-to-Ambient		65	°C/W

Static @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		37		mV/°C	Reference to 25°C, I _D = 2mA ①
R _{DS(on)}	Static Drain-to-Source On-Resistance		2.0	2.5	mΩ	$V_{GS} = 10V, I_D = 57A$
$V_{GS(th)}$	Gate Threshold Voltage	2.2	3.0	3.9	V	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$
	Drain to Source Leakage Current			1.0		$V_{DS} = 40V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source Leakage Current			150	μA	$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
	Gate-to-Source Forward Leakage			100	n 1	$V_{GS} = 20V$
I _{GSS}	Gate-to-Source Reverse Leakage			-100	nA	$V_{GS} = -20V$
R_G	Gate Resistance		2.3		Ω	

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by T_{Jmax} , starting T_J = 25°C, L = 124 μ H, R_G = 50 Ω , I_{AS} = 57A, V_{GS} =10V.
- $\label{eq:local_spin_spin} \ensuremath{ \Im } \quad I_{SD} \leq 57 A, \ di/dt \leq 962 A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175 ^{\circ} C.$
- \odot C_{oss} eff. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- \odot C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- $\ \ \, \bigcirc \ \ \, R_{\theta}$ is measured at T_J approximately 90°C.
- \$ Limited by T_{Jmax} , starting $T_J = 25$ °C, L = 1mH, $R_G = 50\Omega$, $I_{AS} = 29A$, $V_{GS} = 10V$.



Dynamic Electrical Characteristics @ $T_J = 25$ °C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	144			S	$V_{DS} = 10V, I_{D} = 57A$
Q_g	Total Gate Charge		88	132		I _D = 57A
Q_{gs}	Gate-to-Source Charge		22		nC	V _{DS} = 20V
Q_{gd}	Gate-to-Drain Charge		30		IIC	V _{GS} = 10V
Q _{sync}	Total Gate Charge Sync. (Qg – Qgd)		58			
$t_{d(on)}$	Turn-On Delay Time		11			$V_{DD} = 20V$
t _r	Rise Time		42			I _D = 30A
$t_{d(off)}$	Turn-Off Delay Time		56		ns	$R_G = 2.7\Omega$
t _f	Fall Time		36			V _{GS} = 10V④
C _{iss}	Input Capacitance		4549			$V_{GS} = 0V$
C _{oss}	Output Capacitance		689			V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		450		pF	f = 1.0MHz, See Fig.7
Coss eff.(ER)	Effective Output Capacitance (Energy Related)		835			V _{GS} = 0V, V _{DS} = 0V to 32V 6
Coss eff.(TR)	Output Capacitance (Time Related)		981			V_{GS} = 0V, V_{DS} = 0V to 32V $\$$

Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)①			95	_	MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			380		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 57A, V_{GS} = 0V $ ④
dv/dt	Peak Diode Recovery dv/dt③		5.1		V/ns	$T_J = 175^{\circ}C, I_S = 57A, V_{DS} = 40V$
t _{rr}	Reverse Recovery Time		36		ns	$T_J = 25^{\circ}C$ $V_{DD} = 34V$
чт	Reverse Recovery Time		38		115	$T_J = 125^{\circ}C$ $I_F = 57A$,
0	Payaraa Pagayary Chargo		45		200	$T_{J} = 25^{\circ}C$ di/dt = 100A/µs ④
Q_{rr}	Reverse Recovery Charge		49		nC	<u>T_J = 125°C</u>
I _{RRM}	Reverse Recovery Current		2.1		Α	$T_J = 25^{\circ}C$



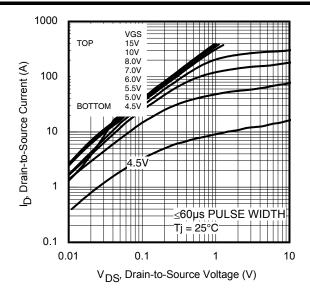


Fig 3. Typical Output Characteristics

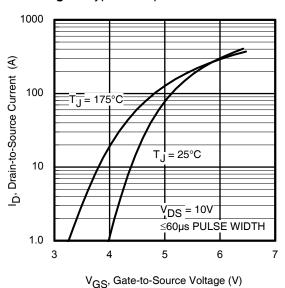


Fig 5. Typical Transfer Characteristics

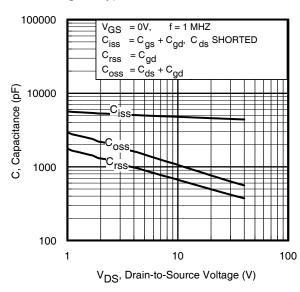


Fig 7. Typical Capacitance vs. Drain-to-Source Voltage

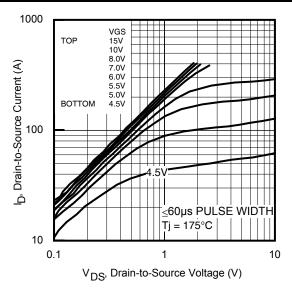


Fig 4. Typical Output Characteristics

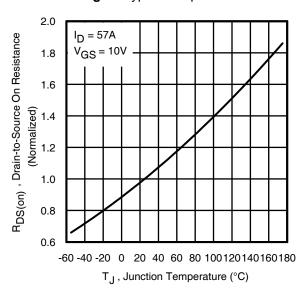


Fig 6. Normalized On-Resistance vs. Temperature

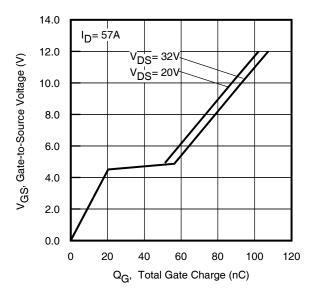


Fig 8. Typical Gate Charge vs. Gate-to-Source Voltage

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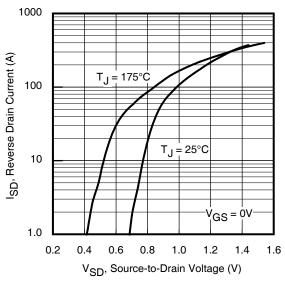


Fig 9. Typical Source-Drain Diode Forward Voltage

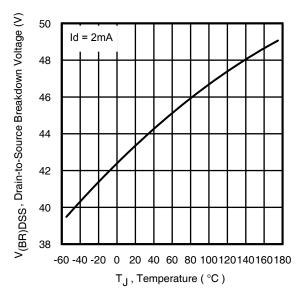


Fig 11. Drain-to-Source Breakdown Voltage

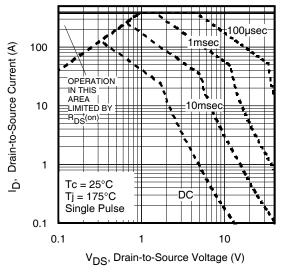


Fig 10. Maximum Safe Operating Area

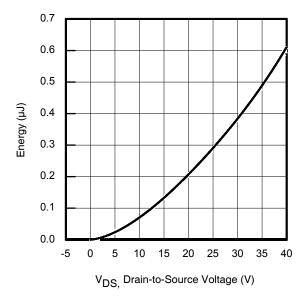


Fig 12. Typical Coss Stored Energy

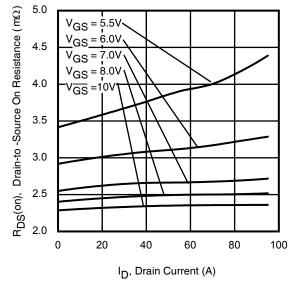


Fig 13. Typical On-Resistance vs. Drain Current



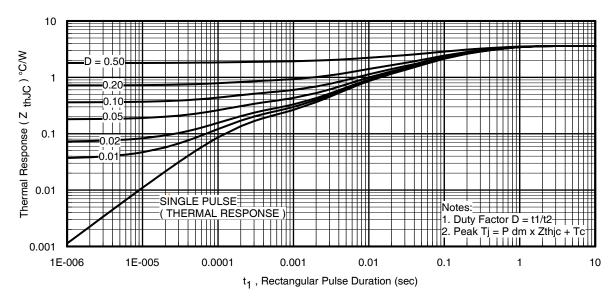


Fig 14. Maximum Effective Transient Thermal Impedance, Junction-to-Case

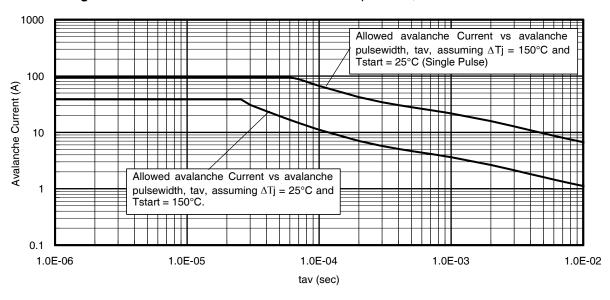


Fig 15. Avalanche Current vs. Pulse Width

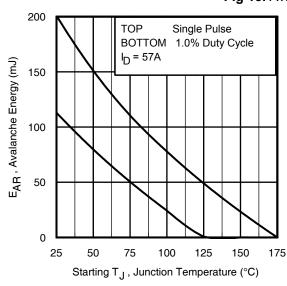


Fig 16. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

1. Avalanche failures assumption:

Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.

- 2. Safe operation in Avalanche is allowed as long asT_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 23a, 23b.
- 4. P_{D (ave)} = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. l_{av} = Allowable avalanche current.
- ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).

 t_{av} = Average time in avalanche.

D = Duty cycle in avalanche = tav f

 $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figures 13)

PD (ave) = 1/2 (1.3·BV·I_{av}) = $\Delta T/Z_{thJC}$

 $I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$

 $E_{AS (AR)} = P_{D (ave)} t_{av}$



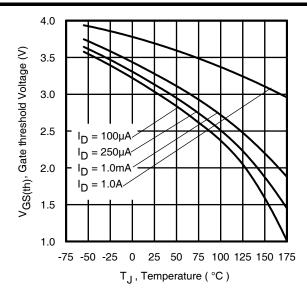


Fig 17. Threshold Voltage vs. Temperature

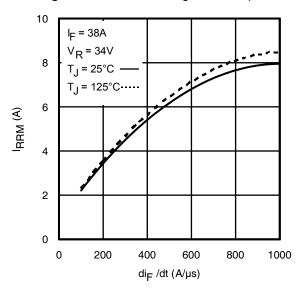


Fig 19. Typical Recovery Current vs. dif/dt

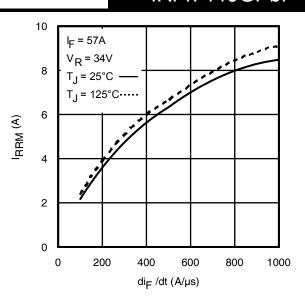


Fig 18. Typical Recovery Current vs. dif/dt

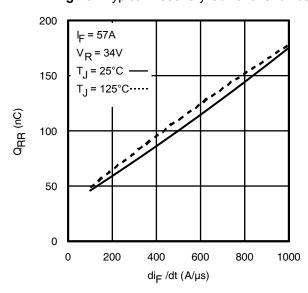


Fig 20. Typical Stored Charge vs. dif/dt

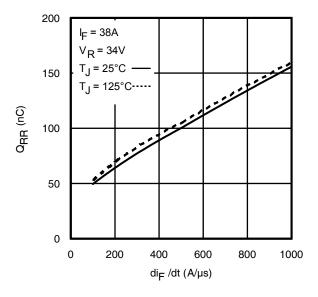


Fig 21. Typical Stored Charge vs. dif/dt



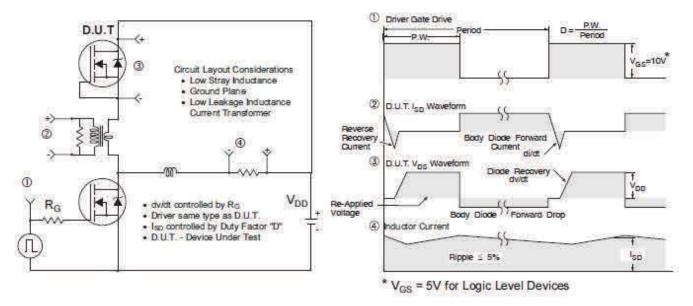


Fig 22. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

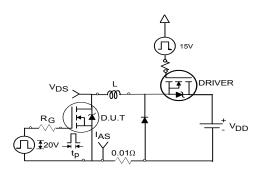


Fig 23a. Unclamped Inductive Test Circuit

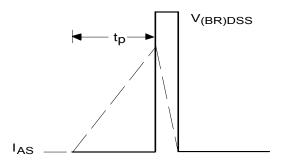


Fig 23b. Unclamped Inductive Waveforms

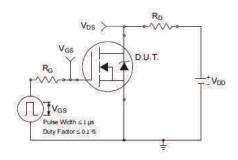


Fig 24a. Switching Time Test Circuit

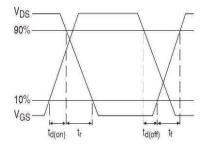


Fig 24b. Switching Time Waveforms

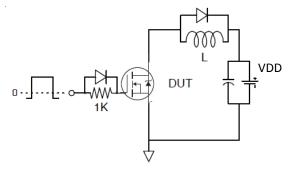


Fig 25a. Gate Charge Test Circuit

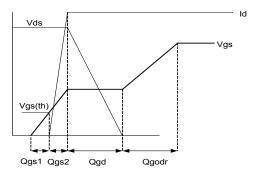
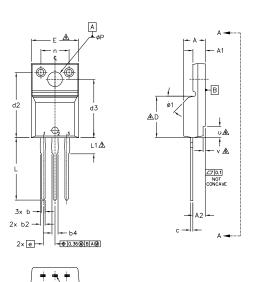


Fig 25b. Gate Charge Waveform

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TO-220 Full-Pak Package Outline (Dimensions are shown in millimeters (inches))



- NOTES:
- 1.0 DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.
- DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTER MOST EXTREMES OF THE PLASTIC BODY.
- DIMENSION 61, 63, 65 & c1 APPLY TO BASE METAL ONLY.
- STEP OPTIONAL ON PLASTIC BODY DEFINED BY DIMENSIONS u & v.
- CONTROLLING DIMENSION: INCHES.

LEAD ASSIGNMENTS

- HEXFET 1.- GATE 2.- DRAIN
- 3 SOURCE
- IGBTs, CoPACK
- 1 GATE
- 2.- COLLECTOR
- 3.- EMITTER

М	2111121113					
B O	MILLIM	ETERS	INC	HES		
L	MIN.	MAX.	MIN.	MA		
А	4.57	4.83	.180	.1		
A1	2.57	2.82	.101	.1		
Α2	2.51	2.92	.099	.1		
b	0.61	0.94	.024	.0		
b1	0.61	0.89	.024	.0		
b2	0.76	1.27	.030	.0		
b3	0.76	1.22	.030	.0		
b4	1.02	1.52	.040	.0		
b5	1.02	1.47	.040	.0		
С	0.33	0.63	.013	.0		
c1	0.33	0.58	.013	.0		
D	8.66	9.80	.341	.3		
d1	15.80	16.13	.622	.6		
d2	13.97	14.22	.550	.5		
d3	12.29	12.93	.484	.5		

DIMENSIONS

0

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5

4

4

3

6 6

MAX.

.190

.111

.115

.037 .035

.050 .048

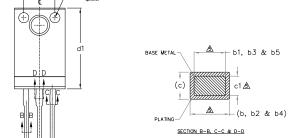
.060 .058

.025 .023

.386

.635

.560



d3	12.29	12.93	.484	.509	
E	9.63	10.74	.379	.423	
е	2.54	BSC	.100	BSC	
L	13.21	13.72	.520	.540	
L1	3.10	3.68	.122	.145	
n	6.05	6.60	.238	.260	
ØΡ	3.05	3.45	.120	.136	
u	2.39	2.49	.094	.098	
V	0.41	0.51	.016	.020	
ø1	-	45°	_	45°	

TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRFI840G WITH ASSEMBLY LOT CODE 3432 ASSEMBLED ON WW 24, 2001 IN THE ASSEMBLY LINE "K"

PART NUMBER INTERNATIONAL IRFI840G RECTIFIER IOR 124K LOGO 32 34 DATE CODE YEAR 1 = 2001ASSEMBLY WEEK 24 LOT CODE LINE K

Note: "P" in assembly line position indicates "Lead-Free"

TO-220AB Full-Pak packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

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Qualification Information[†]

Qualification I avai	Industrial			
Qualification Level	(per JEDEC JESD47F) ††			
Moisture Sensitivity Level	TO-220 Full-Pak N/A			
RoHS Compliant	Yes			

- † Qualification standards can be found at International Rectifier's web site: http://www.irf.com/product-info/reliability/
- †† Applicable version of JEDEC standard at the time of product release.

Revision History

Date	Comments
11/18/2014	• Updated E _{AS (L =1mH)} = 407mJ on page 2
	• Updated note 8 "Limited by T_{Jmax} , starting $T_J = 25$ °C, $L = 1$ mH, $R_G = 50\Omega$, $I_{AS} = 29$ A, $V_{GS} = 10$ V". on page 2
12/16/2015	Updated datasheet with corporate template
12/10/2013	 Corrected typo test condition for Switch time ID from "57A" to "30A" on page 3.

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